

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT		Docket Number 40103/00501	
Application No. 10/033,975	Filing Date December 19, 2001	Inventor(s) James HARRISON et al.	

Invention Title

IMPROVED METHOD AND APPARATUS FOR WAFER-LEVEL TESTING OF SEMICONDUCTOR LASERS

Address to:

f hereby certify that this correspondence to being depented with the United States Postal Carring on that place that in on crucing addressed to: Assistant Commissioner for Petente, Muching

Commissioner for Patents P.O. Box 2327

2/8/02

Arlington, VA 22202

- In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance 1. with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorneys for Applicants hereby bring the following references (cited in the specification of the aboveidentified application) to the attention of the Examiner. The references are listed on the attached modified PTO Form No. 1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.
- A copy of each patent, publication or other information listed on the modified PTO form 2. 1449 is enclosed.

As this Information Disclosure Statement is being submitted prior to receipt of the first Office Action, in this case, no fee is believed to be required. However, if any fee is required, please use deposit account number 50-1492. A copy of this paper is enclosed for that purpose.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

ATTY. DOCKET NO.

40103/00501

APPLICANT(S)

James Harrison and David L. Heald

FILING DATE

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SERIAL NO.

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GROUP

2858

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U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT NUMBER	PATENT DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	5,498,973	12 Mar. 1996	Cavaliere et al.	324/765	22
	6,057,918	2 May 2000	Geary et al.	356/218	
	6,137,305	24 Oct. 2000	Freund et al.	324/767	
	6,255,707	3 Jul. 2001	Bylsma et al.	257/414	
	6,264,852	24 Jul. 2001	Herchen et al.	216/60	

If necessary.

FOREIGN PATENT DOCUMENTS

					TRANSLATION	
EXAMINER INITIAL	DOCUMENT NUMBER	FILING DATE	COUNTRY	CLASS/ SUBCLASS	YES	NO
	-					

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER	DATE CONSIDERED

EXAMINER: Initial if citation is considered, whether or not citation is in conformance with M.P.E.P. 609, strike out citation if not in conformance and not considered. Include copy of this form with next communication to applicant.